



DATA SHEET

Model PDW50F-15

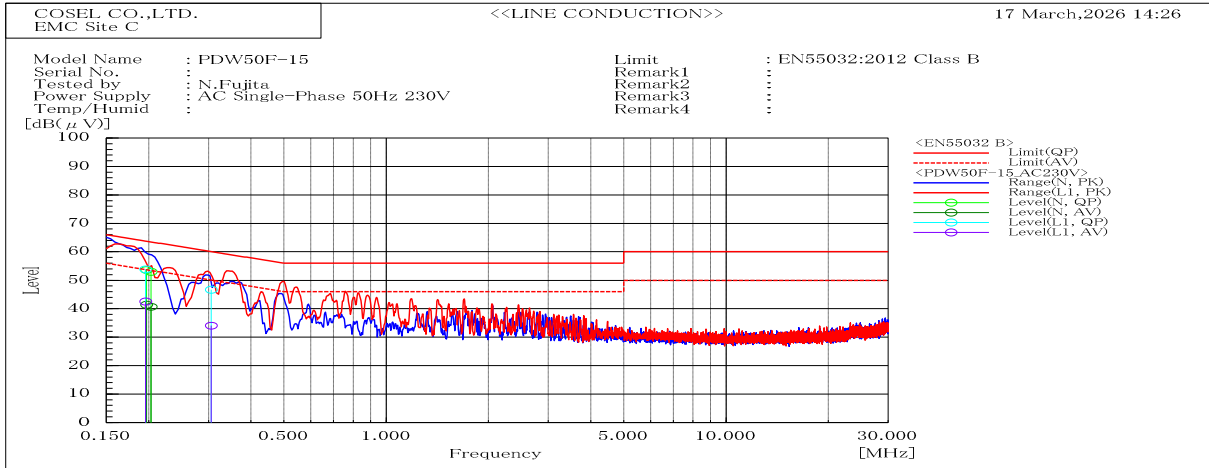
Date 11-Apr-26

Test EMI
Line conduction & Radiated emission

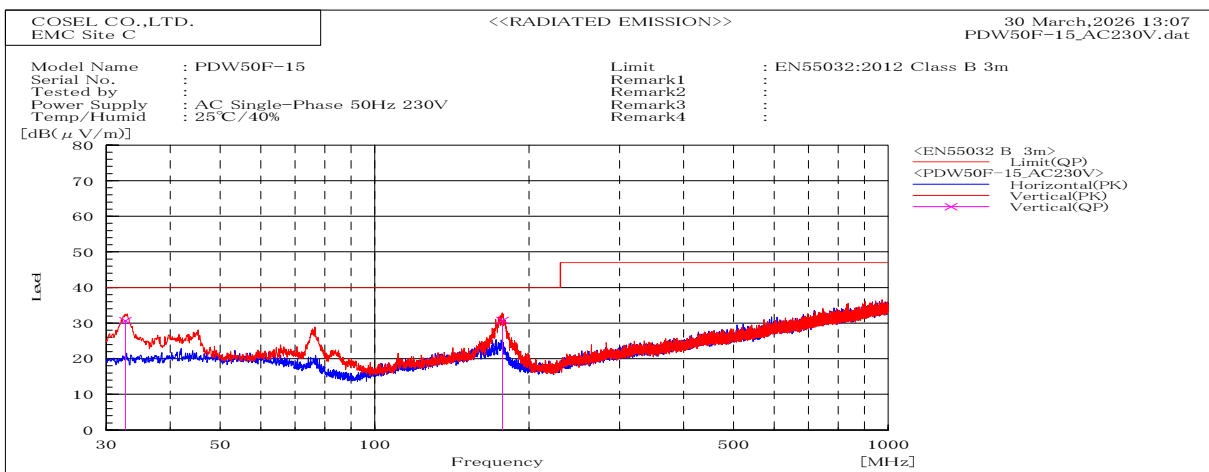
Temp. 25 degreeC

Humid. 40 %RH

Tested by T.Sakuma



Frequency	Line	Level		Limit		Margin		Pass/Fail	Remark
MHz		dB(μV)		dB(μV)		dB			
		QP	AV	QP	AV	QP	AV		
0.196	L1	53.8	42.5	63.8	53.8	10	11.3	Pass	
0.197	N	53.6	41.4	63.7	53.7	10.1	12.3	Pass	
0.203	N	53	40.7	63.5	53.5	10.5	12.8	Pass	
0.306	L1	46.7	34	60.1	50.1	13.4	16.1	Pass	

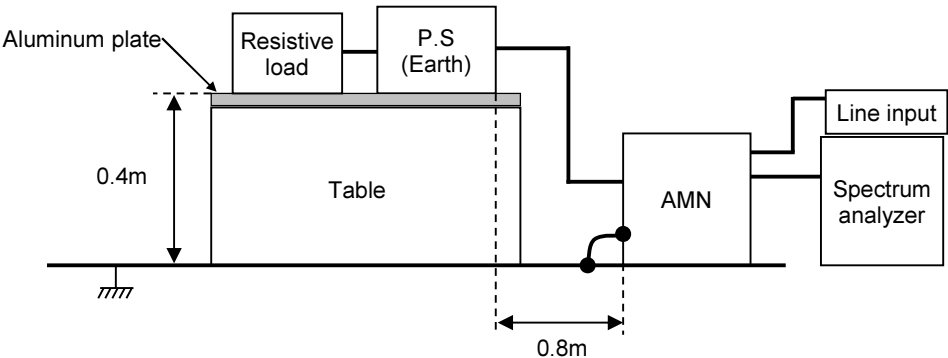


Frequency MHz	Polarization	Stability	Level	Limit	Margin	Pass/Fail	Height cm	Angle deg	Remark
			dB(μV/m) QP	dB(μV/m) QP	dB QP				
32.699	V	Stable	30.7	40	9.3	Pass	100.2	320.8	
177.502	V	Stable	30.8	40	9.2	Pass	100.2	359.1	

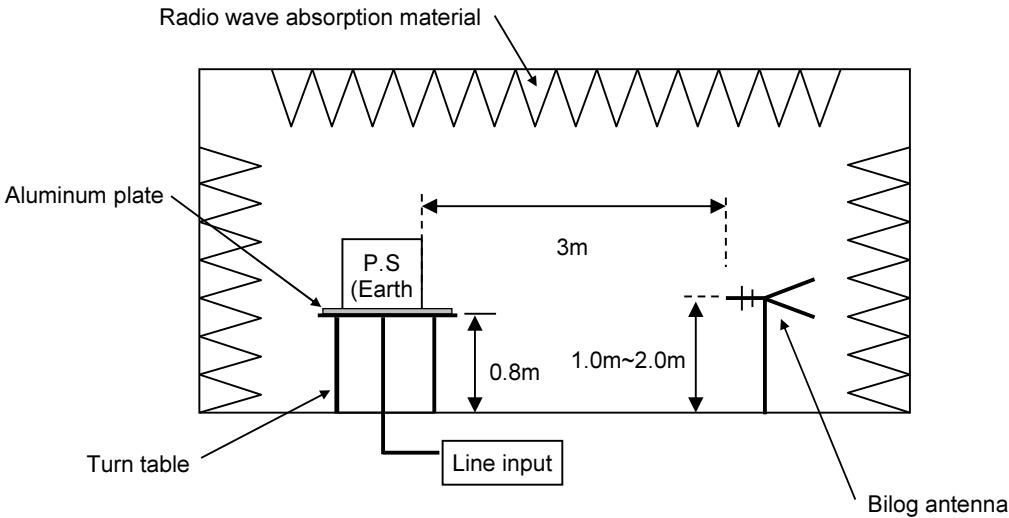


DATA SHEET		Date	11-Apr-26
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Sakuma

1. Line conduction



2. Radiated emission





Conditions

Test : EMI
Model Name : PDW50F-15

1. Line conduction



2. Radiated emission

